## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10731730	SONI ET AL.
Examiner	Art Unit
Flores, Leon	2611

SEARCHED					
Class	Subclass	Date	Examiner		
375	355	2/15/2007	LF		
370	206, 338	2/15/2007	LF		

SEARCH NOTES				
Search Notes	Date	Examiner		
Consulted with SPE David Payne in regards to the patentability of claim 1	2/20/2007	LF		
Search in NPL (IEEE)	2/15/2007	LF		
Checked for possible Double Patenting.	2/15/2007	LF		
Consulted with SPE David Payne in regards to the amendments.	9/7/2007	LF		
Consulted with SPE David Payne in regards to the amendments.	12/11/2007	LF		
Consulted with SPE Shuwang Liu in regards to the RCE.	2/8/2008	LF		
Consulted with SPE David Payne in regards to the RCE.	2/21/2008	LF		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

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